

Notice of References Cited	Application/Control No. 10/587,606		Applicant(s)/Patent Under Reexamination FINE ET AL.	
	Examiner LEI YAO		Art Unit 1642	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,545,727	08-1996	Hoffman et al.	536/23.4
	B	US-			
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	D	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	WO2003105880	Sec 2003		Pincus	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Reed et al., PNAS vol 92, page 9455-9459, 1995
	V	p53 sequence search of SEQ ID NO: 1
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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